



TEST REPORT

Report Number..... : ZKT-211156112E

Date of Test..... : Nov.15, 2021 to Nov.19, 2021

Date of issue..... : Nov.19, 2021

Total number of pages..... : 32

Test Result : PASS

Testing Laboratory..... : Shenzhen ZKT Technology Co., Ltd.Address : 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue,
Fuhai Street, Bao'an District, Shenzhen, China.**Applicant's name** : Shenzhen Weiyin Technology Co.,Ltd.Address : Room 201, Building E, No.1, Xinyuan Industrial Zone, Xinmu
Community, Pinghu Street, Longgang District, Shenzhen.**Manufacturer's name** : Shenzhen Weiyin Technology Co.,Ltd.Address : Room 201, Building E, No.1, Xinyuan Industrial Zone, Xinmu
Community, Pinghu Street, Longgang District, Shenzhen.**Test specification:**Standard..... : EN IEC 55014-1:2021, EN IEC 55014-2:2021
EN IEC 61000-3-2:2019/A1:2021, EN 61000-3-3:2013+A1:2019
EN 61000-4-2:2009, EN IEC 61000-4-3:2020,
EN 61000-4-4:2012, EN 61000-4-5:2014+A1:2017,
EN 61000-4-6:2014, EN 61000-4-8:2010,
EN IEC 61000-4-11:2020

Test procedure..... : /

Non-standard test method : N/A

Test Report Form No..... : TRF-EL-142_V0**Test Report Form(s) Originator**..... : ZKT Testing**Master TRF** : Dated: 2020-01-06

This device described above has been tested by ZKT, and the test results show that the equipment under test (EUT) is in compliance with the 2014/30/EU Directive requirements. And it is applicable only to the tested sample identified in the report.

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Product name..... : SOLAR PANELTrademark : 

Model/Type reference..... : WYC1802-SP

WYC1805-SP,WYC1808-SP,WYC1813-SP,WYC1815-SP,
WYC1817-SP,WYC1828-SP,WYC1901-SP,WYC1904-SP,
WYC1916-SP,WYC1917-SP,WYC2021-SP,WYC1811-SP,
WYC1812-SP,WYC1821-SP,WYC1908-SP,WYS1801-SP,
WYS1802-SP,WYS1803-SP,WYS1804-SP,WYS1805-SP,
WYS1807-SP,WYS1816-SP,WYS1817-SP,WYS1818-SP,
WYB2001-SP,WYB2005-SP,WYB2006-SP,WYB2007-SP,
WYB2008-SP,WYB2011-SP,WYC1902-SP,WYC1920-SP,
WYC1903-SP,WYC1829-SP,WYC1820-SP,WYC1822-SP,
WYC1823-SP,WYC1835-SP,WYC1826-SP,WYC1928-SP

Ratings..... : Input: DC 16.5V



Testing procedure and testing location:

Testing Laboratory.....: Shenzhen ZKT Technology Co., Ltd.

Address.....: 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

Tested by (name + signature).....: Alen He

Reviewer (name + signature).....: Joe Liu

Approved (name + signature).....: Lake Xie





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1. VERSION

Report No.	Version	Description	Approved
ZKT-211156112E	Rev.01	Initial issue of report	Nov.19, 2021



2. GENERAL INFORMATION

2.1 Description of Device (EUT)

EUT	SOLAR PANEL WYC1802-SP WYC1805-SP,WYC1808-SP,WYC1813-SP,WYC1815-SP, WYC1817-SP,WYC1828-SP,WYC1901-SP,WYC1904-SP, WYC1916-SP,WYC1917-SP,WYC2021-SP,WYC1811-SP, WYC1812-SP,WYC1821-SP,WYC1908-SP,WYS1801-SP, Model NumberWYS1802-SP,WYS1803-SP,WYS1804-SP,WYS1805-SP, WYS1807-SP,WYS1816-SP,WYS1817-SP,WYS1818-SP, WYB2001-SP,WYB2005-SP,WYB2006-SP,WYB2007-SP, WYB2008-SP,WYB2011-SP,WYC1902-SP,WYC1920-SP, WYC1903-SP,WYC1829-SP,WYC1820-SPWYC1822-SP, WYC1823-SP,WYC1835-SP,WYC1826-SP,WYC1928-SP
Trademark	
Model Difference	Only for different model name.
Power Supply	Input:DC 16.5V
Note:	

2.2 Tested System Details

None.

2.3 Test Facility

Shenzhen ZKT Technology Co., Ltd.
Add. : 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China

FCC Test Firm Registration Number: 692225
Designation Number: CN1299
IC Registered No.: 27033

2.4 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	Value (dB)
Conducted Emission (150K-30MHZ)	3.20
Radiated disturbance30MHz-1000MHz	4.80



2.5 Test Instrument Used

For Conducted Emission at the mains terminals Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	LISN	R&S	ENV216	101471	Sep. 22, 2021	Sep. 21, 2022
2	LISN	CYBERTEK	EM5040A	E1850400149	Sep. 22, 2021	Sep. 21, 2022
3	Test Cable	N/A	C01	N/A	Sep. 22, 2021	Sep. 21, 2022
4	Test Cable	N/A	C02	N/A	Sep. 22, 2021	Sep. 21, 2022
5	EMI Test Receiver	R&S	ESRP3	101946	Sep. 22, 2021	Sep. 21, 2022
6	Absorbing Clamp	DZ	ZN23201	N/A	Sep. 22, 2021	Sep. 21, 2022

For Radiated Emission Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	Bilog Antenna	Schwarzbeck	VULB9168	00877	Sep. 22, 2021	Sep. 21, 2022
2	Loop Antenna	SCHWARZBECK	FMZB1519B	014	Sep. 22, 2021	Sep. 21, 2022
3	Test Cable	N/A	R-01	N/A	Sep. 22, 2021	Sep. 21, 2022
4	Test Cable	N/A	R-02	N/A	Sep. 22, 2021	Sep. 21, 2022
5	EMI Test Receiver	R&S	ESCI7	101169	Sep. 22, 2021	Sep. 21, 2022
6	Antenna Mast	EM	SC100_1	N/A	N/A	N/A
7	Turn Table	EM	SC100	N/A	N/A	N/A
8	Spectrum Analyzer	KEYSIGHT	9020A	MY5537083 5	Sep. 22, 2021	Sep. 21, 2022
9	Horn Antenna (1GHz-18GHz)	Schwarzbeck	BBHA9120D	1541	Sep. 22, 2021	Sep. 21, 2022
10	Horn Antenna (18GHz-40GHz)	A.H. System	SAS-574	588	Sep. 22, 2021	Sep. 21, 2022
11	Amplifier (30-1000MHz)	EM Electronics	EM330 Amplifier	N/A	Sep. 22, 2021	Sep. 21, 2022
12	Amplifier (1GHz-40GHz)	全聚达	DLE-161	097	Sep. 22, 2021	Sep. 21, 2022

For Harmonic & Flicker Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	Harmonic & Flicker	LAPLACE INSTRUMENTS	C2000A	311370	Sep. 22, 2021	Sep. 21, 2022
2	AC Power Source	LAPLACE INSTRUMENTS	C2000A	311370	Sep. 22, 2021	Sep. 21, 2022

For Electrostatic Discharge Immunity Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	ESD TEST GENERATOR	HTEC	HESD16	N/A	Sep. 22, 2021	Sep. 21, 2022



For RF Field Strength Susceptibility Test(SMQ)

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	Signal Generator	R&S	SMT 06	832080/007	Sep. 22, 2021	Sep. 21, 2022
2	Log-Bicon Antenna	Schwarzbeck	VULB9161	4022	Sep. 22, 2021	Sep. 21, 2022
3	Power Amplifier	AR	150W1000M1	320946	Sep. 22, 2021	Sep. 21, 2022
4	Microwave Horn Antenna	AR	AT4002A	321467	Sep. 22, 2021	Sep. 21, 2022
5	Power Amplifier	AR	25S1G4A	308598	Sep. 22, 2021	Sep. 21, 2022

For Electrical Fast Transient /Burst Immunity Test /For Surge Test /For Voltage Dips Interruptions Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	Surge Generator	HTEC	HCOMPAC T5	202501	Sep. 22, 2021	Sep. 21, 2022
2	DIPS Generator	HTEC	HV1P16T	202101	Sep. 22, 2021	Sep. 21, 2022
3	EFT/B Generator	HTEC	HCOMPAC T5	202501	Sep. 22, 2021	Sep. 21, 2022
4	EFT/B Clamp	HTEC	H3C	N/A	Sep. 22, 2021	Sep. 21, 2022

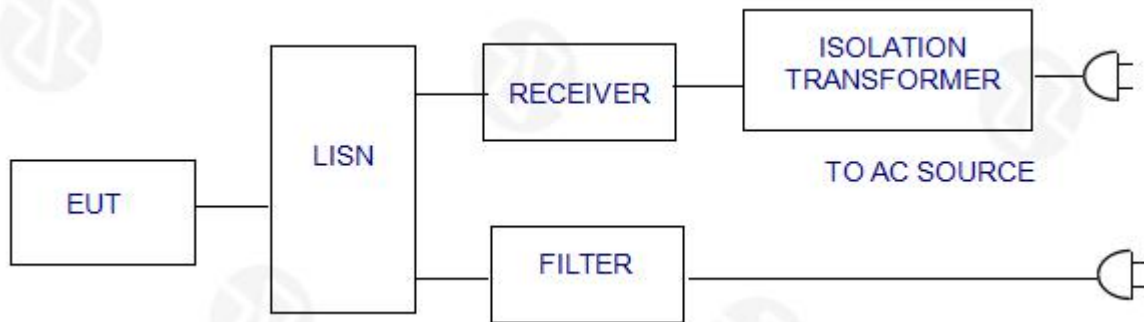
For Injected Currents Susceptibility Test

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until
1	Signal Generator	IFR	2023A	202301/368	Sep. 22, 2021	Sep. 21, 2022
2	Power Amplifier	AR	75A250AM1	0320709	Sep. 22, 2021	Sep. 21, 2022
3	CDN	FCC	FCC-801-M2	06043	Sep. 22, 2021	Sep. 21, 2022
4	EM Clamp	FCC	F-203I-23MM	504	Sep. 22, 2021	Sep. 21, 2022



3. CONDUCTED EMISSION AT THE MAINS TERMINALS TEST

3.1 Block Diagram Of Test Setup



3.2 Test Standard

EN IEC 55014-1:2021

3.3 Power Line Conducted Emission Limit

Frequency MHz	Limits dB(μV)	
	Quasi-peak Level	Average Level
0.15 ~ 0.50	66 ~ 56*	59 ~ 46*
0.50 ~ 5.00	56	46
5.00 ~ 30.00	60	50

Notes: 1. *Decreasing linearly with logarithm of frequency.
2. The lower limit shall apply at the transition frequencies.

3.4 EUT Configuration on Test

The following equipments are installed on conducted emission test to meet EN 55014-1 requirement and operating in a manner which tends to maximize its emission characteristics in a normal application.

3.5 Operating Condition of EUT

- 3.5.1 Setup the EUT and simulators as shown in Section 3.1.
- 3.5.2 Turn on the power of all equipments.
- 3.5.3 Let the EUT work in test modes and test it.

3.6 Test Procedure

The EUT is put on the ground and connected to the AC mains through a Artificial Mains Network (AMN). This provided a 50ohm coupling impedance for the tested equipments. Both sides of AC line are checked to find out the maximum conducted emission levels according to the **EN55014-1** regulations during conducted emission test.

The bandwidth of the test receiver (R&S Test Receiver ESCI) is set at 10KHz.

The frequency range from 150 KHz to 30 MHz is investigated.

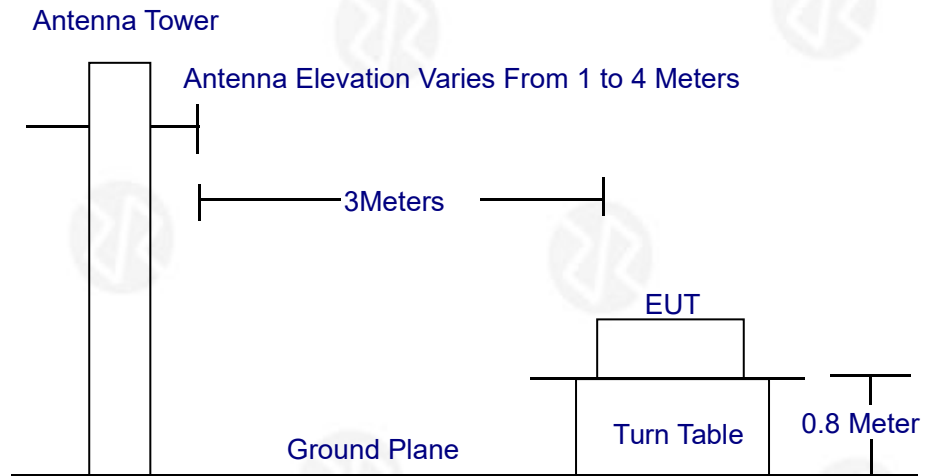
3.7 Test Result

The EUT is powered by DC only. The test items is not applicable.



4. RADIATION EMISSION TEST

4.1 Block Diagram of Test Setup



4.2 Test Standard

EN IEC 55014-1:2021

4.3 Radiation Limit

Frequency MHz	Distance (Meters)	Field Strengths Limits dB(μ V)/m
30 ~ 230	3	40.0
230 ~ 1000	3	47.0

Remark:

- (1) Emission level (dB(μ V)/m) = 20 log Emission level (μ V/m)
- (2) The smaller limit shall apply at the cross point between two frequency bands.
- (3) Distance refers to the distance in meters between the measuring instrument, antenna and the closed point of any part of the device or system.

4.4 EUT Configuration on Test

The EN 55014-1 regulations test method must be used to find the maximum emission during radiated emission test.

The configuration of EUT is the same as used in conducted emission test.

Please refer to Section 2.2.

4.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.2 except the test set up replaced as Section 4.1.

4.6 Test Procedure

The EUT and its simulators are placed on a turned table that is 0.8 meter above the ground. The turned table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna that is mounted on the antenna tower. The antenna can move up and down between 1 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated biconical and log periodical antenna) is used as receiving antenna. Both horizontal and



vertical polarization of the antenna is set on test. In order to find the maximum emission levels, the interface cable must be manipulated according to EN 55014-1 on radiated emission test.

The bandwidth setting on the field strength meter (R&S Test Receiver ESCI) is set at 120KHz.

The frequency range from 30MHz to 1000MHz is checked.

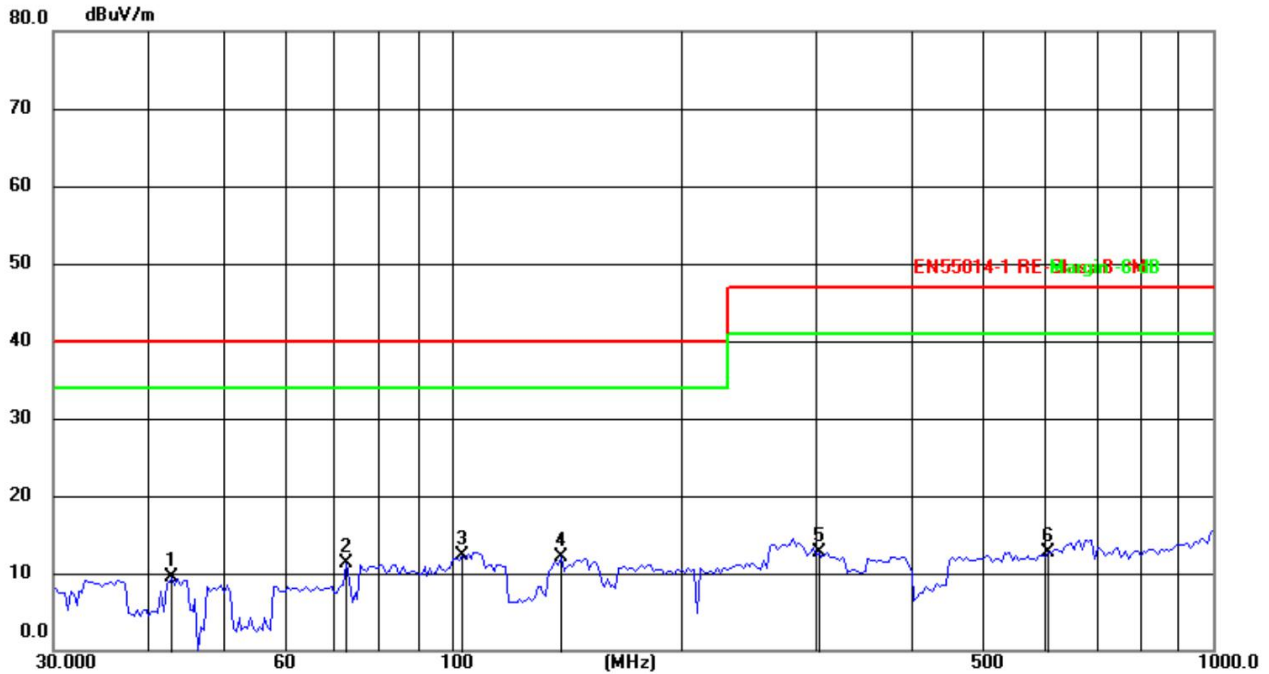
4.7 Test Result

PASS

Please refer to the following page.



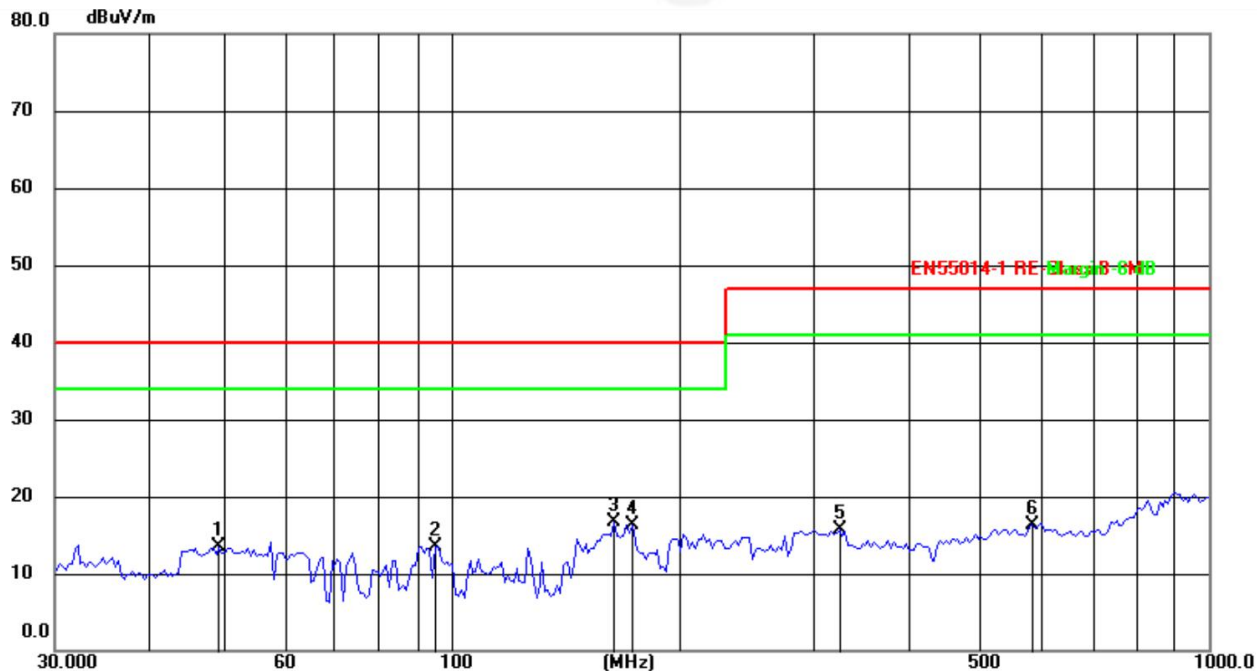
Radiation Emission Test Data			
Temperature:	24.5 °C	Relative Humidity:	54%
Pressure:	1009hPa	Phase :	Horizontal
Test Voltage :	DC 16.5V	Test Mode:	Working



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	42.9750	23.56	-14.10	9.46	40.00	-30.54	QP				
2	72.7189	28.86	-17.59	11.27	40.00	-28.73	QP				
3	103.2609	31.99	-19.65	12.34	40.00	-27.66	QP				
4	139.1170	29.49	-17.40	12.09	40.00	-27.91	QP				
5	303.5437	31.68	-18.97	12.71	47.00	-34.29	QP				
6	606.7219	23.47	-10.68	12.79	47.00	-34.21	QP				



Radiation Emission Test Data			
Temperature:	24.5 °C	Relative Humidity:	54%
Pressure:	1009hPa	Phase :	Vertical
Test Voltage :	DC 16.5V	Test Mode:	Working

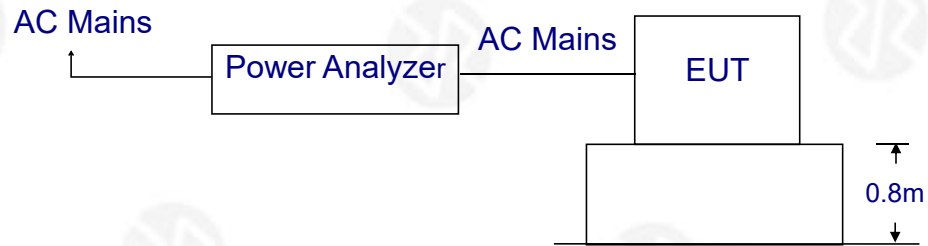


No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Azimuth (deg.)	P/F	Remark
1	49.4460	30.72	-17.27	13.45	40.00	-26.55	QP				
2	95.4269	34.82	-21.34	13.48	40.00	-26.52	QP				
3	164.3301	37.37	-20.75	16.62	40.00	-23.38	QP				
4	173.2050	37.03	-20.69	16.34	40.00	-23.66	QP				
5	325.5958	35.11	-19.48	15.63	47.00	-31.37	QP				
6	585.8156	26.66	-10.32	16.34	47.00	-30.66	QP				



5. HARMONIC CURRENT EMISSION TEST

5.1 Block Diagram of Test Setup



5.2 Test Standard

EN IEC 61000-3-2:2019/A1:2021

5.3 Operating Condition of EUT

- 5.3.1 Setup the EUT as shown in Section 5.1.
- 5.3.2 Turn on the power of all equipments.
- 5.3.3 Let the EUT work in test mode and test it.

5.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

5.5 Test Results

The EUT is powered by DC only. The test items is not applicable.



6. VOLTAGE FLUCTUATIONS & FLICKER TEST

6.1 Block Diagram of Test Setup

Same as Section 6.1.

6.2 Test Standard

EN 61000-3-3:2013+A1:2019

6.3 Operating Condition of EUT

Same as Section 5.3.. The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

Flicker Test Limit

Test items	Limits
Pst	1.0
dc	3.3%
Tmax	4.0%
dt	Not exceed 3.3% for 500ms

6.4 Test Procedure

The power cord of the EUT is connected to the output of the test system. Turn on the power of the EUT and use the test system to test the harmonic current level.

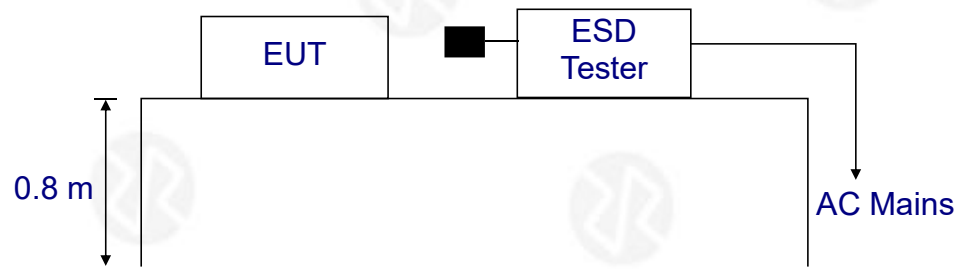
6.5 Test Results

The EUT is powered by DC only. The test items is not applicable.



7. ELECTROSTATIC DISCHARGE IMMUNITY TEST

7.1 Block Diagram of Test Setup



7.2 Test Standard

EN IEC 55014-2:2021, EN 61000-4-2:2009

Severity Level: 3 / Air Discharge: ± 8 KV
Level: 2 / Contact Discharge: ± 4 KV

7.3 Severity Levels and Performance Criterion

7.3.1 Severity level

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)
1.	± 2	± 2
2.	± 4	± 4
3.	± 6	± 8
4.	± 8	± 15
X	Special	Special

7.3.2 Performance criterion : B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

7.4 EUT Configuration

The following equipments are installed on Electrostatic Discharge Immunity test to meet



EN IEC 55014-2:2021, EN 61000-4-2:2009, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 2.4.

7.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 3.5 except the test setup replaced by Section 7.1.2.

7.6 Test Procedure

7.6.1 Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

7.6.2 Contact Discharge:

All the procedure shall be same as Section 7.6.1. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

7.6.3 Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

7.6.4 Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are complete illuminated.

7.7 Test Results

PASS

Please refer to the following page.

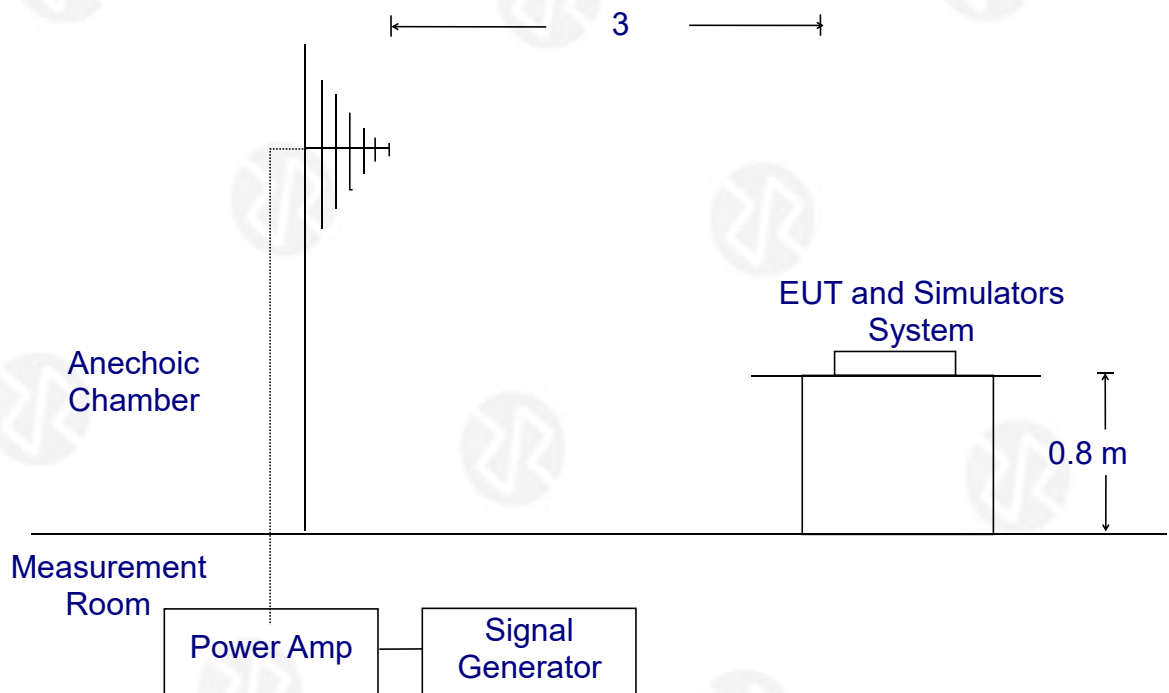


ESD Test Data				
Temperature:	24.5℃	Humidity:	53%	
Power Supply :	DC 16.5V	Test Mode:	On	
Air Discharge: ± 8KV Contact Discharge: ± 4KV				
Test Points	Air Discharge	Contact Discharge	Performance Criterion	Result
Enclosure	±2,4,8KV	N/A	B	PASS
Slit	±2,4,8KV	N/A	B	PASS
Metal Part	N/A	±2,4 KV	B	PASS
VCP	N/A	±2,4 KV	B	PASS
HCP	N/A	±2,4 KV	B	PASS
Note: N/A				



8. RF FIELD STRENGTH SUSCEPTIBILITY TEST

8.1 Block Diagram of Test Setup



8.2 Test Standard

EN IEC 55014-2:2021,
EN IEC 61000-4-3:2020

Severity Level 2, 3V / m

8.3 Severity Levels and Performance Criterion

8.3.1. Severity level

Level	Field Strength V/m
1.	1
2.	3
3.	10
X.	Special

8.3.2. Performance criterion: A

- A、 The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance



level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i

- B、 The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C、 Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

8.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

8.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.5 except the test setup replaced by Section 8.1.

8.6 Test Procedure

The EUT and its simulators are placed on a turn table which is 0.8 meter above ground. EUT is set 3 meter away from the transmitting antenna which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna are set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

All the scanning conditions are as follows :

Condition of Test	Remarks
1. Fielded Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 – 1000 MHz
4. Dwell time of radiated	0.0015 decade/s
5. Waiting Time	1 Sec.

8.7 Test Results

PASS

Please refer to the following page.



R/S Test Data			
Temperature : 25℃		Humidity : 53%	
Field Strength: 3 V/m		Criterion: A	
Power Supply: DC 16.5V		Frequency Range: 80 MHz to 1000 MHz	
Modulation: <input checked="" type="checkbox"/> AM <input type="checkbox"/> Pulse <input type="checkbox"/> none 1 KHz 80%			
Test Mode : On			
	Frequency Range : 80-1000MHz		
Steps	1 %		
	Horizontal	Vertical	Result
Front	A	A	Pass
Right	A	A	Pass
Rear	A	A	Pass
Left	A	A	Pass
Note: N/A			



9. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

9.1 Block Diagram of EUT Test Setup



9.2 Test Standard

EN IEC 55014-2:2021, EN 61000-4-4:2012

9.3 Severity Levels and Performance Criterion

Severity Level 2 at 1KV, Pulse Rise time & Duration: 5 nS / 50 nS

Severity Level:

Open Circuit Output Test Voltage $\pm 10\%$		
Level	On power ports	On I/O(Input/Output) Signal data and control ports
1.	0.5KV	0.25KV
2.	1KV	0.5KV
3.	2KV	1KV
4.	4KV	2KV
X.	Special	Special

Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.



9.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN 61000-4-4:2012, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application. The configuration of EUT is the same as used in conducted emission test. Please refer to Section 3.4.

9.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.6 except the test setup replaced by Section 9.1.

9.6 Test Procedure

EUT shall be placed 0.8m high above the ground reference plane which is a min.1m*1m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m

9.6.1. For input and output AC power ports:

The EUT is connected to the power mains by using a coupling device which couples the EFT interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration of the test is 2 minutes.

9.7 Test Results

The EUT is powered by DC only. The test items is not applicable.



10. SURGE TEST

10.1 Block Diagram of EUT Test Setup



10.2 Test Standard

EN IEC 55014-2:2021, EN 61000-4-5:2014+A1:2017

10.3 Severity Levels and Performance Criterion

Severity Level: Line to Line, Level 2 at 1KV;

Severity Level: Line to Earth, Level 3 at 2KV.

Severity Level	Open-Circuit Test Voltage (KV)
1.	0.5
2.	1.0
3.	2.0
4.	4.0
X.	Special

Performance criterion: B

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.



10.4 EUT Configuration on Test

The following equipments are installed on Electrical Fast Transient/Burst Immunity test to meet EN IEC 55014-2:2021, EN61000-4-5:2014, requirement and operating in a manner which tends to maximize its emission characteristics in a normal application

The configuration of EUT is the same as used in conducted emission test.
Please refer to Section 3.4.

10.5 Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 2.7 except the test setup replaced by Section 10.1.

10.6 Test Procedure

- 1) Set up the EUT and test generator as shown on section 10.1
- 2) For line to line coupling mode, provide a 1KV 1.2/50us voltage surge (at open-circuit condition) and 8/20us current surge to EUT selected points.
- 3) At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are conducted during test.
- 4) Different phase angles are done individually.
- 5) Repeat procedure 2) to 4) except the open-circuit test voltage change from 1KV to 2KV for line to earth coupling mode test.
- 6) Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

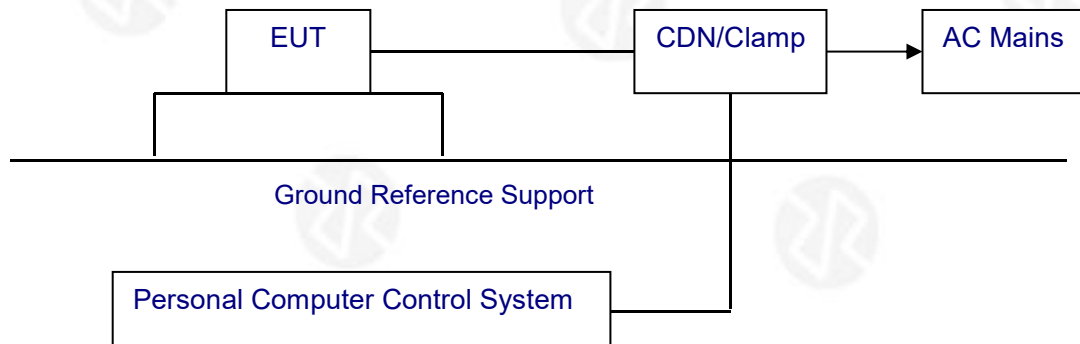
10.7 Test Result

The EUT is powered by DC only. The test items is not applicable.



11. INJECTED CURRENTS SUSCEPTIBILITY TEST

11.1 Block Diagram of EUT Test Setup



11.2 Test Standard

EN IEC 55014-2:2021, EN61000-4-6:2014

11.3 Severity Levels and Performance Criterion

Severity Level 2: 3V(rms), 150KHz ~ 80MHz

Severity Level:

Level	Field Strength V
1.	1
2.	3
3.	10
X.	Special

Performance criterion: A

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

11.4 EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test.
Please refer to Section 2.8.



11.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.8 except the test set up replaced as Section 11.1.

11.6 Test Procedure

- 1) Set up the EUT, CDN and test generator as shown on section 11.1
- 2) Let EUT work in test mode and measure.
- 3) The EUT and supporting equipments are placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane at above 0.1-0.3m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- 4) The disturbance signal described below is injected to EUT through CDN.
- 5) The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 6) The frequency range is swept from 150KHz to 80MHz using 3V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave
- 7) The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.
- 8) Recording the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

11.7 Test Result

The EUT is powered by DC only. The test items is not applicable.



12. VOLTAGE DIPS AND INTERRUPTIONS TEST

12.1 Block Diagram of EUT Test Setup



12.2 Test Standard

EN IEC 55014-2:2021, EN IEC 61000-4-11:2020

12.3 Severity Levels and Performance Criterion

Severity Level:

Input and Output AC Power Ports.

- ☒ Voltage Dips.
- ☒ Voltage Interruptions.

Environmental Phenomena	Test Specification	Units	Performance Criterion
Voltage Dips	70	% Reduction period	C
	25		
	40	% Reduction period	C
	10		
Voltage Interruptions	0	% Reduction period	C
	0.5		

Performance criterion: B, C, C

- A. The apparatus shall continue to operate as intended during the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as i
- B. The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level (or permissible loss of performance) specified by the manufacturer, when the apparatus is used as intended. During the test, degradation of performance is allowed, however, no change of actual operating state or stored data is allowed. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and from what the user may reasonably expect from the apparatus if used as intended.
- C. Temporary loss of function is allowed, provided the function is self- recoverable or can be restored by the operation of the controls, or by any operation specified in the instructions for use.

12.4 EUT Configuration on Test

The configuration of EUT is the same as used in conducted emission test.
Please refer to Section 2.10.



12.5 Operating Condition of EUT

Same as conducted emission test, which is listed in Section 2.10 except the test set up replaced as Section 13.1.

12.6 Test Procedure

- 1) Set up the EUT and test generator as shown on section 13.1
- 2) The interruption is introduced at selected phase angles with specified duration. There is a 3mins minimum interval between each test event.
- 3) After each test a full functional check is performed before the next test.
- 4) Repeat procedures 2 & 3 for voltage dips, only the level and duration is changed.
- 5) Record any degradation of performance.

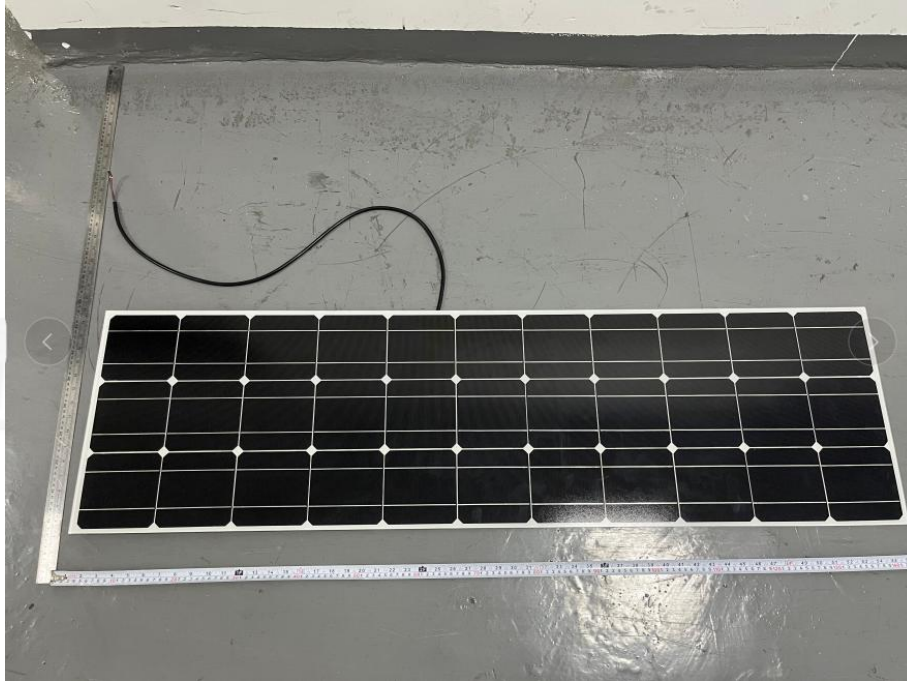
12.7 Test Result

The EUT is powered by DC only. The test items is not applicable.

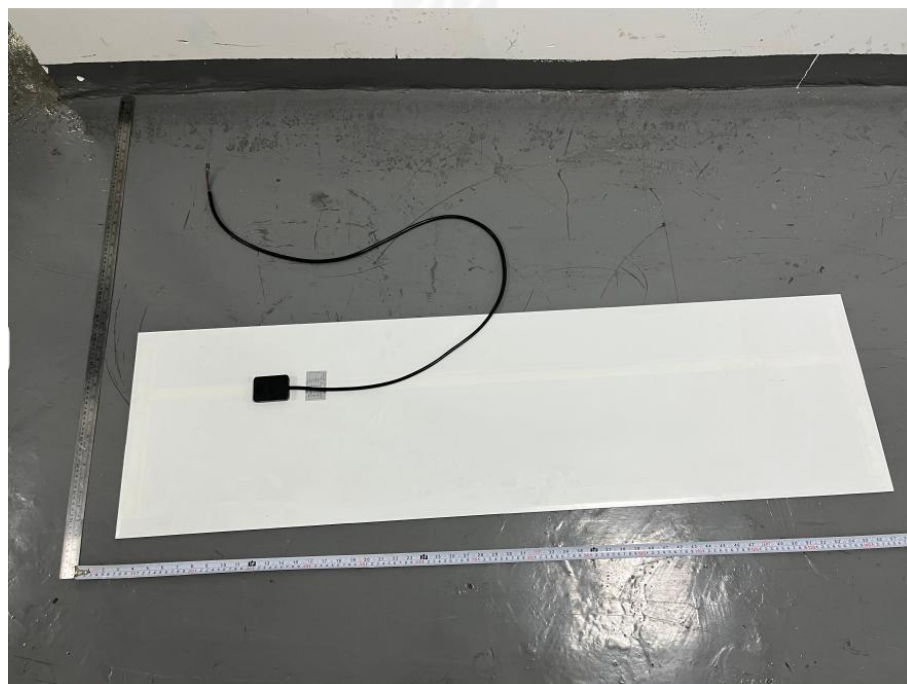


13. EUT PHOTOGRAPHS

EUT Photo 1



EUT Photo 2





EUT Photo 3

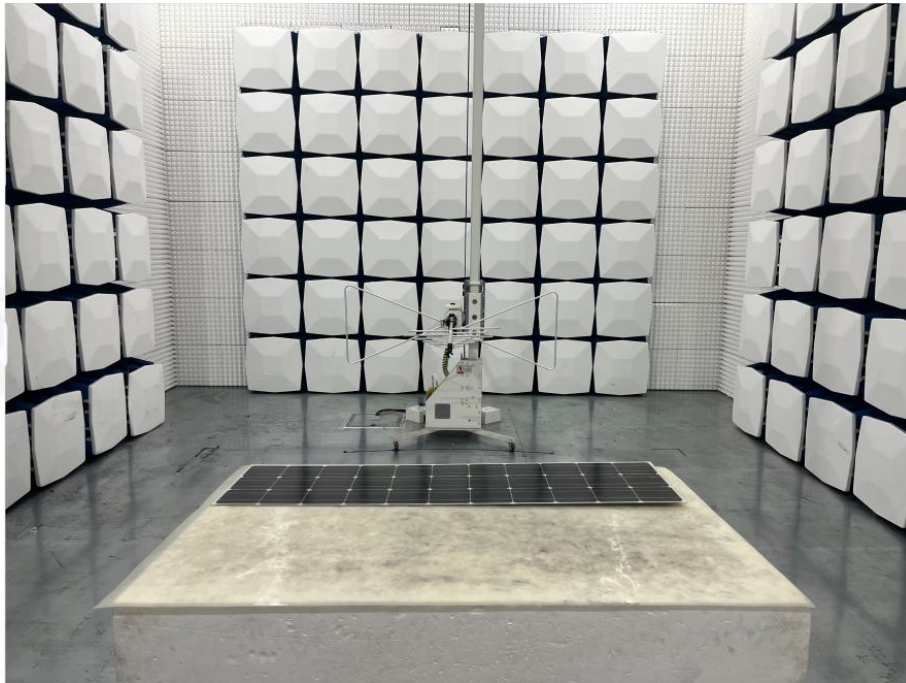




14. EUT TEST PHOTOGRAPHS

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EUT Photo 4



***** END OF REPORT *****